

Freeform Search

Database:	<div style="border: 1px solid black; padding: 2px;"> US Pre-Grant Publication Full-Text Database US Patents Full-Text Database US OCR Full-Text Database EPO Abstracts Database JPO Abstracts Database Derwent World Patents Index IBM Technical Disclosure Bulletins </div>
Term:	<div style="border: 1px solid black; padding: 2px;"> L18 and (bipolar) </div>
Display:	<div style="border: 1px solid black; padding: 2px;">10</div>
Documents in Display Format:	<div style="border: 1px solid black; padding: 2px;">-</div>
Starting with Number	<div style="border: 1px solid black; padding: 2px;">1</div>
Generate: <input type="radio"/> Hit List <input checked="" type="radio"/> Hit Count <input type="radio"/> Side by Side <input type="radio"/> Image	

Search

Clear

Interrupt

Search History

DATE: Thursday, January 05, 2006 [Printable Copy](#) [Create Case](#)

Set Name Query

side by side

Hit Count Set Name

result set

DB=USPT; PLUR=YES; OP=ADJ

L19 L18 and (bipolar)

1 L19

L18 6736540.pn.

1 L18

DB=PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=ADJ

L17 (thermal sens\$5 transistors) adj5 (integrated circuit or IC or wafer)

0 L17

L16 thermal sens\$5 transistors adj5 chip

0 L16

L15 temperature sens\$5 transistors adj5 chip

7 L15

L14 temperature measur\$3 transistors adj5 IC

0 L14

L13 temperature sens\$5 transistors adj5 IC

2 L13

L12 temperature sens\$4 transistors adj5 IC

2 L12

DB=EPAB; PLUR=YES; OP=ADJ

L11 KR-2003042942-A.did.

0 L11

L10 KR-434237-B.did.

0 L10

DB=PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=ADJ

L9 temperature sens\$4 transistors adj5 integrated circuit

3 L9

L8 transistors adj5 integrated circuit

21414 L8

L7 transistors on IC

0 L7

<u>L6</u>	L1 and (Vbe)	33	<u>L6</u>
<u>L5</u>	L2 and (Vbe)	1	<u>L5</u>
<u>L4</u>	L3 and (Vbe)	5	<u>L4</u>
<u>L3</u>	L1 and (second transistor)	109	<u>L3</u>
<u>L2</u>	L1 and (plurality transistors or plurality semiconductors)	74	<u>L2</u>
<u>L1</u>	374/\$.ccls.	28913	<u>L1</u>

END OF SEARCH HISTORY

Freeform Search

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Term:	<div style="border: 1px solid black; padding: 2px;"> L72 and (transistor) </div>
Display:	<div style="border: 1px solid black; padding: 2px;">10</div>
Documents in Display Format: <div style="border: 1px solid black; padding: 2px;">-</div>	
Starting with Number <div style="border: 1px solid black; padding: 2px;">1</div>	
Generate: <input type="radio"/> Hit List <input checked="" type="radio"/> Hit Count <input type="radio"/> Side by Side <input type="radio"/> Image	

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Set

Name Query

side by
side

DB=PGPB,USPT,USOC,EPAB,JPAB; PLUR=YES; OP=ADJ

L73 L72 and (transistor)

L72 L68 and (plurality thermal sensors)

L71 L68 and (plurality sens\$5 diodes)

L70 L68 and (plurality sens\$5 transistors)

L69 L68 and (plurality sens\$4 transistors)

L68 L67 and (IC or integrated circuit or chip or wafer)

L67 (374/170,172,178,141,137,166,163;327/493,504,505,512,513;361/103,365/212,211;324/760,765,
[CCLS])

DB=PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=ADJ

L66 simultaneously obtain\$3 temperature different locations

L65 simultaneously acces\$4 temperature different locations

L64 simultaneously sens\$3 temperature different locations

L63 simultaneously measur\$3 temperature different locations

L62 simultaneously measure temperature different locations

L61 L60 and (IC or integrated circuit or chip or wafer or temperature or thermal)

L60 (plurality sens\$3 transistors)
L59 (plurality sens\$3 trnsistors) and (IC or chip or integrated circuit or wafer)
L58 L40 and (plurality sens\$3 transistors)
L57 L54 and (plurality sensing transistors)
L56 L54 and (plurality locations)
L55 L54 and (different locations)
L54 L52 and (simultaneous\$2)
L53 L52 and (simultaneous\$2 temperature)
L52 L40 and (chip or IC or intergrated circuit or wafer)
DB=PGPB; PLUR=YES; OP=ADJ
L51 L49 and (n-1)
L50 L49 and (individually or selectively or simultaneously)
L49 20040001527
L48 L44 and (selectively or simultaneously)
L47 L44 and (independently)
L46 L44 and (N-1)
L45 L44 and (n-1)
L44 20040005127
DB=PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=ADJ
L43 L2 and (npn adj5 pnp)
L42 L40 and (npn adj5 pnp)
L41 L40 and (parallel transistors)
L40 374/\$.ccls.
L39 parallel transistors
L38 parallel npn pnp
L37 parallel pnp npn
L36 transistor invers\$3 parallel transistor
L35 L34 same (inverse parallel)
L34 transistor connection
L33 L31 and (pins or access points)
L32 L31 and (n pins)
L31 L30 same (transistors)
L30 inverse parallel
L29 (inverse parallel) same (transistors) samw (pin\$1)
L28 inverse parallel transistors
L27 inverse transistor\$1 pair
L26 inverse pair\$1 transistor\$1
L25 L24 and (n pins)
L24 n(n-1)
L23 n(n-1) pairs
L22 L21 and (temperature or thermal)

L21 L20 and (pins)
L20 L19 and (transistors)
L19 257/48
L18 L16 and (temperature or thermal)
L17 L15 and (n pins)
L16 L15 and (pins)
L15 L14 and (transistors)
L14 L13 and (transistors or semiconductors)
L13 438/14
L12 L9 and (pins)
L11 L7 and (n pins)
L10 L9 and (n pins)
L9 L7 and (transistors)
L8 L7 and (antiparallel transistors)
L7 438/18
L6 L2 and (inverse connection)
L5 L2 and (antiparallel)
L4 L3 and (antiparallel)
L3 L2 and (transistor\$1)
L2 327/512
L1 antiparallel transistors

END OF SEARCH HISTORY